## WHAT IS CLAIMED IS:

1. A reactor for growing a gallium containing single crystal,
comprising:
a multi-zone heater;
a growth zone, wherein said multi-zone heater maintains at least one
substrate within said growth zone at a growth temperature greater than 850° C;
an extended gallium source within a multi-zone gallium source zone,
wherein said multi-zone heater maintains a first portion of said extended gallium source
at a first temperature greater than 450° C while simultaneously maintaining a second
portion of said extended gallium source at a second temperature in the range of 30° C to
100° C, wherein upon reaction initiation said second portion comprises at least 50 percent
of said extended gallium source;
a halide reaction gas source coupled to said multi-zone gallium source
zone;
an inert gas source coupled to said multi-zone gallium source zone to
transport a first reaction product from said multi-zone gallium source zone to said growth
zone; and
a reaction gas source coupled to said growth zone.
2. The reactor of claim 1, wherein upon reaction initiation said second
portion comprises at least 90 percent of said extended gallium source.
The reactor of claim 1, wherein said second temperature is in the
range of 30° C to 40° C.
4. The reactor of claim 1, further comprising a first aluminum source
zone, wherein said halide reaction gas source and said inert gas source are coupled to said
first aluminum source zone, and wherein said multi-zone heater maintains a first
aluminum source within said first aluminum source zone to a third temperature greater
than 700° C.
5. The reactor of claim 4, further comprising a second aluminum
source zone, wherein said halide reaction gas source and said inert gas source are coupled

- 3 to said second aluminum source zone, and wherein said multi-zone heater maintains a
- 4 second aluminum source within said second aluminum source zone to a fourth greater
- 5 than 700° C.
- 1 6. The reactor of claim 1, wherein said multi-zone heater is a multi-
- 2 zone resistive heater furnace.
- The reactor of claim 1, further comprising an acceptor impurity
- 2 source zone, wherein said inert gas source is coupled to said acceptor impurity source
- 3 zone, and wherein said multi-zone heater maintains an acceptor impurity within said
- 4 acceptor impurity source zone at a third temperature.
- 1 8. The reactor of claim 1, further comprising a donor impurity source
- 2 zone, wherein said inert gas source is coupled to said donor impurity source zone, and
- 3 wherein said multi-zone heater maintains a donor impurity within said donor impurity
- 4 source zone at a third temperature.
- 1 9. The reactor of claim 1, further comprising means for transferring
- 2 said at least one substrate within said growth zone to a second growth zone.
- 1 10. The reactor of claim 9, wherein said multi-zone heater maintains
- 2 said at least one substrate within said second growth zone at a third temperature.
- 1 The reactor of claim 10, wherein said growth temperature is in the
- 2 range of 1,000° C to 1,100° C and wherein said third temperature is in the range of
- 3 850° C to 1,000° C.
- 1 12. The reactor of claim 1, wherein said halide gas source supplies HCl
- 2 gas.
- 1 13. The reactor of claim 1, wherein said reaction gas source supplies
- 2 ammonia gas.